

**Search Notes**

Application/Control No.

10/820,325

Examiner

Nathan Wiehe

Applicant(s)/Patent under  
Reexamination

LEE ET AL.

Art Unit

3745

**SEARCHED**

Class	Subclass	Date	Examiner
416	97R, 96R, 96A	7/18/2005	NEW
415	115, 116	7/18/2005	NEW

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
416/.97R, 96R, 96A 415/115,116 Christopher Verdier	7/18/2005	NEW
Text Search (See EAST search history)	7/18/2005	NEW
PLUS Search	7/18/2005	NEW